Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/813,932	SCHROER, DAN J.	
Examiner	Art Unit	
Steven S. Paik	2876	

SEARCHED					
Class	Subclass	Date	Examiner		
235	385				
	375				
	380,382				
	435				
	462.01				
	487				
283	74, 109	8/1/2005	SSP		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	!			
<u>.</u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR <sup>.</sup>
EAST		
Text search	8/1/2005	SSP